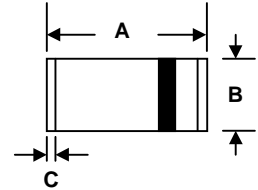


Silicon Epitaxial Planar Switching Diode

Fast switching diode in MiniMELF case especially suited for automatic surface mounting



MiniMELF		
Dim	Min	Max
A	3.30	3.60
B	1.40	1.50
C	0.25	0.33
All Dimensions in mm		

Absolute Maximum Ratings ( $T_a = 25^\circ\text{C}$ )

Parameter	Symbol	Value	Unit
Peak Reverse Voltage	$V_{RM}$	100	V
Reverse Voltage	$V_R$	75	V
Average Rectified Forward Current	$I_{F(AV)}$	200	mA
Non-repetitive Peak Forward Surge Current	$I_{FSM}$	0.5	A
		1	
		4	
Power Dissipation	$P_{tot}$	500 <sup>1)</sup>	mW
Junction Temperature	$T_j$	175	$^\circ\text{C}$
Storage Temperature Range	$T_{stg}$	- 65 to + 175	$^\circ\text{C}$

<sup>1)</sup> Valid provided that electrodes are kept at ambient temperature.

**Characteristics at  $T_a = 25^\circ\text{C}$** 

Parameter	Symbol	Min.	Max.	Unit
Reverse Breakdown Voltage tested with 100 $\mu\text{A}$ Pulses	$V_{(BR)R}$	100	-	V
Forward Voltage at $I_F = 10 \text{ mA}$	$V_F$	-	1	V
Leakage Current at $V_R = 20 \text{ V}$ at $V_R = 75 \text{ V}$ at $V_R = 20 \text{ V}, T_j = 150^\circ\text{C}$	$I_R$ $I_R$ $I_R$	- - -	25 5 50	nA $\mu\text{A}$ $\mu\text{A}$
Capacitance at $V_R = 0, f = 1 \text{ MHz}$	$C_{tot}$	-	4	pF
Voltage Rise when Switching ON tested with 50 mA Forward Pulses $t_p = 0.1 \text{ s}$ , Rise Time < 30 ns, $f_p = 5 \text{ to } 100 \text{ KHz}$	$V_{fr}$	-	2.5	V
Reverse Recovery Time at $I_F = 10 \text{ mA}$ to $I_R = 1 \text{ mA}$ , $I_{rr} = 0.1 \times I_R, V_R = 6 \text{ V}$ , $R_L = 100 \Omega$	$t_{rr}$	-	4	ns

